## Application/Control No. Applicant(s)/Patent Under Reexamination 10/801,219 MEGAW ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Y. J. Han 2838 **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-6,556,155 04-2003 Wiles, Jr., William W. Α 341/119 12-2004 В US-2004/0257150 Farooqui, Arshad Suhail 327/539 С US-US-D US-Е US-F US-G US-Н US-1 J US-K US-L US-

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